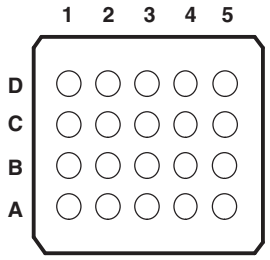
TXS0108E
8-BIT BIDIRECTIONAL VOLTAGE-LEVEL TRANSLATOR FOR OPEN-DRAIN AND PUSH-PULL APPLICATIONS

SCES642–DECEMBER 2007

FEATURES

- **1.2 V to 3.6 V on A Port and 1.65 V to 5.5 V on B Port ($V_{CCA} \leq V_{CCB}$)**
- **V_{CC} Isolation Feature – If Either V_{CC} Input Is at GND, All Outputs Are in the High-Impedance State**
- **Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II**
- **ESD Protection Exceeds JESD 22 (A Port)**
  - **2000-V Human-Body Model (A114-B)**
  - **150-V Machine Model (A115-A)**
  - **1000-V Charged-Device Model (C101)**
- **IEC 61000-4-2 ESD (B Port)**
  - **±8-kV Contact Discharge**
  - **±6-kV Air-Gap Discharge**

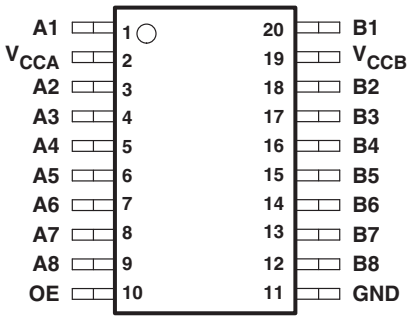
ZXY PACKAGE
(BOTTOM VIEW)



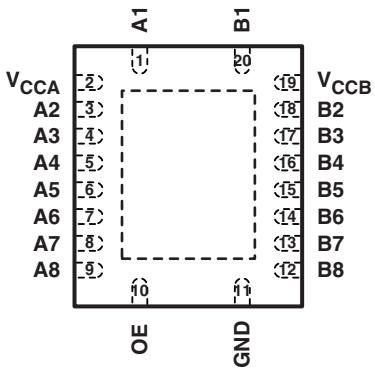
TERMINAL ASSIGNMENTS

	1	2	3	4	5
D	V_{CCB}	B2	B4	B6	B8
C	B1	B3	B5	B7	GND
B	A1	A3	A5	A7	OE
A	V_{CCA}	A2	A4	A6	A8

PW PACKAGE
(TOP VIEW)



RGY PACKAGE
(TOP VIEW)



DESCRIPTION/ORDERING INFORMATION

This 8-bit noninverting translator uses two separate configurable power-supply rails. The A port is designed to track V_{CCA}. V_{CCA} accepts any supply voltage from 1.2 V to 3.6 V. The B port is designed to track V_{CCB}. V_{CCB} accepts any supply voltage from 1.65 V to 5.5 V. This allows for low-voltage bidirectional translation between any of the 1.2-V, 1.5-V, 1.8-V, 2.5-V, 3.3-V, and 5-V voltage nodes.

When the output-enable (OE) input is low, all outputs are placed in the high-impedance state.

To ensure the high-impedance state during power up or power down, OE should be tied to GND through a pulldown resistor; the minimum value of the resistor is determined by the current-sourcing capability of the driver.

Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of the Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

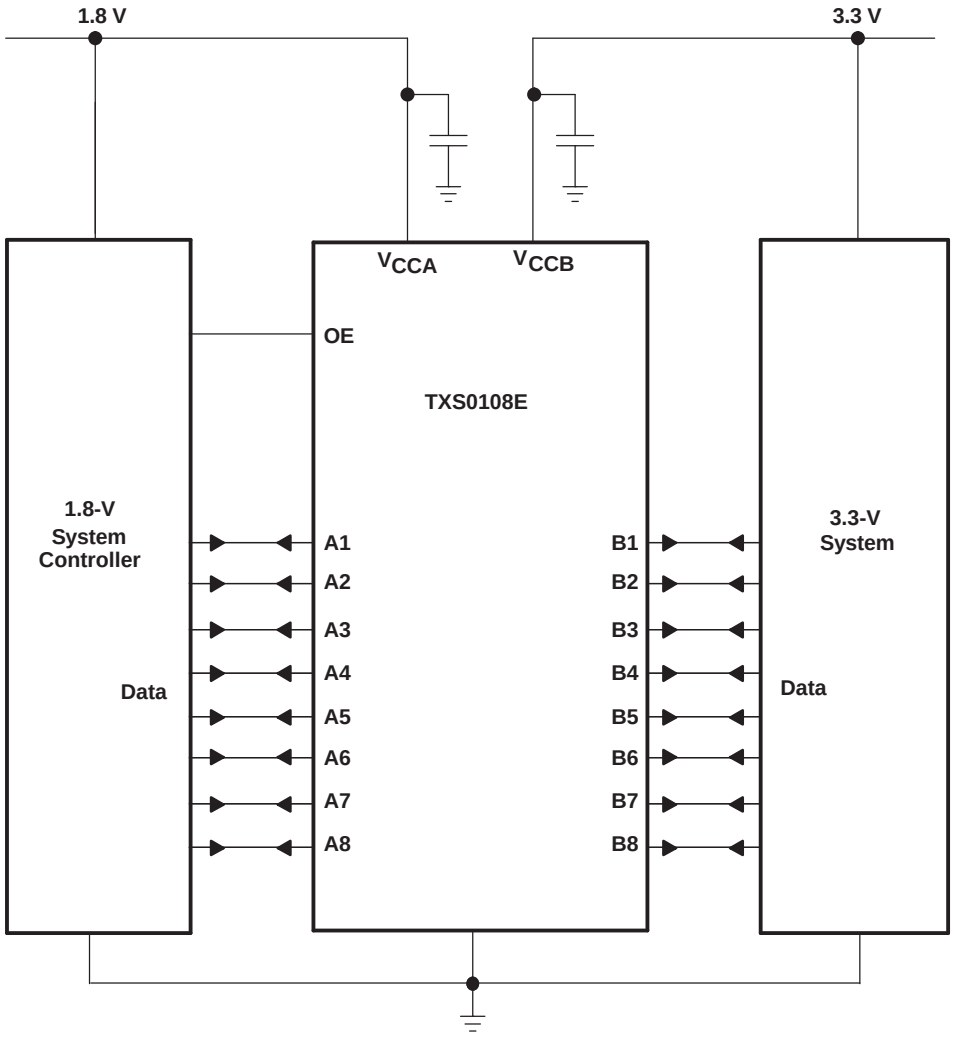
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ORDERING INFORMATION

T_A	PACKAGE(1)(2)		ORDERABLE PART NUMBER	TOP-SIDE MARKING
–40°C to 85°C	QFN – RGY	Reel of 1000	TXS0108ERGYR	YF08E
	TSSOP – PW	Reel of 2000	TXS0108EPWR	YF08E
	UFBGA – ZXY	Reel of 2500	TXS0108EZXYR	YF08E

(1) Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.
(2) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.

TYPICAL OPERATING CIRCUIT



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ABSOLUTE MAXIMUM RATINGS(1)

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V_{CCA}	Supply voltage range		–0.5	4.6	V
V_{CCB}	Supply voltage range		–0.5	5.5	V
V_I	Input voltage range(2)	A port	–0.5	4.6	V
		B port	–0.5	6.5	
V_O	Voltage range applied to any output in the high-impedance or power-off state(2)	A port	–0.5	4.6	V
		B port	–0.5	6.5	
V_O	Voltage range applied to any output in the high or low state(2)(3)	A port	–0.5	V_{CCA} + 0.5	V
		B port	–0.5	V_{CCB} + 0.5	
I_{IK}	Input clamp current	V_I < 0		–50	mA
I_{OK}	Output clamp current	V_O < 0		–50	mA
I_O	Continuous output current			±50	mA
	Continuous current through V_{CCA}, V_{CCB}, or GND			±100	mA
T_{stg}	Storage temperature range		–65	150	°C

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
(2) The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.
(3) The value of V_{CCA} and V_{CCB} are provided in the recommended operating conditions table.

THERMAL IMPEDANCE RATINGS

				UNIT
θ_{JA}	Package thermal impedance	PW package(1)	70	°C/W
		RGY package(2)	TBD	
		ZXY package(1)	47	

(1) The package thermal impedance is calculated in accordance with JESD 51-5.
(2) The package thermal impedance is calculated in accordance with JESD 51-7.

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RECOMMENDED OPERATING CONDITIONS[1][2]

			V_{CCA}	V_{CCB}	MIN	MAX	UNIT
V_{CCA}	Supply voltage[3]				1.2	3.6	V
V_{CCB}					1.65	5.5	
V_{IH}	High-level input voltage	A-Port I/Os	1.2 V to 1.95 V	1.65 V to 5.5 V	V_{CCI} – 0.2	5.5	V
			1.95 V to 3.6 V		V_{CCI} – 0.4	5.5	
		B-Port I/Os	1.2 V to 3.6 V	1.65 V to 5.5 V	V_{CCI} – 0.4	5.5	
		OE			V_{CCA} × 0.65	5.5	
V_{IL}	Low-level input voltage	A-Port I/Os	1.2 V to 1.95 V	1.65 V to 5.5 V	0	0.15	V
			1.95 V to 3.6 V		0	0.15	
		B-Port I/Os	1.2 V to 3.6 V	1.65 V to 5.5 V	0	0.15	
		OE			0	V_{CCA} × 0.35	
Δt/Δv	Input transition rise or fall rate	A-Port I/Os push-pull driving	1.2 V to 3.6 V	1.65 V to 5.5 V		10	ns/V
		B-Port I/Os push-pull driving					
		Control input					
T_A	Operating free-air temperature				–40	85	°C

(1) V_{CCI} is the V_{CC} associated with the data input port.
(2) V_{CCO} is the V_{CC} associated with the output port.
(3) V_{CCA} must be less than or equal to V_{CCB}, and V_{CCA} must not exceed 3.6 V.

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ELECTRICAL CHARACTERISTICS(1)(2)(3)

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	V_{CCA}	V_{CCB}	T_A = 25°C			–40°C to 85°C		UNIT
					MIN	TYP	MAX	MIN	MAX	
V_{OHA}		I_{OH} = –20 µA, $V_{IB} \geq V_{CCB}$ – 0.4 V	1.2 V	1.65 V to 5.5 V		V_{CCA} × 0.67	0.25			V
			1.4 V to 3.6 V					V_{CCA} × 0.67		
V_{OLA}		I_{OL} = 135 µA, $V_{IB} \leq$ 0.15 V	1.2 V	1.65 V to 5.5 V			0.25			V
		I_{OL} = 180 µA, $V_{IB} \leq$ 0.15 V	1.4 V						0.4	
		I_{OL} = 220 µA, $V_{IB} \leq$ 0.15 V	1.65 V						0.4	
		I_{OL} = 300 µA, $V_{IB} \leq$ 0.15 V	2.3 V						0.4	
		I_{OL} = 400 µA, $V_{IB} \leq$ 0.15 V	3 V						0.55	
V_{OHB}		I_{OH} = –20 µA, $V_{IA} \geq V_{CCA}$ – 0.2 V	1.2 V	1.65 V to 5.5 V						V
			1.4 V to 3.6 V					V_{CCB} × 0.67		
V_{OLB}		I_{OL} = 220 µA, $V_{IA} \leq$ 0.15 V	1.2 V to 3.6 V	1.65 V					0.4	V
		I_{OL} = 300 µA, $V_{IA} \leq$ 0.15 V		2.3 V					0.4	
		I_{OL} = 400 µA, $V_{IA} \leq$ 0.15 V		3 V					0.55	
		I_{OL} = 620 µA, $V_{IA} \leq$ 0.15 V		4.5 V					0.55	
I_I	OE	$V_I = V_{CCI}$ or GND	1.2 V	1.65 V to 5.5 V			±1		2	µA
I_{OZ}	A or B port		1.2 V	1.65 V to 5.5 V			±1		±2	µA
I_{CCA}		$V_I = V_O$ = Open, I_O = 0	1.2 V	1.65 V to 5.5 V		1.5			±2	µA
			1.4 V to 3.6 V	2.3 V to 5.5 V					2	
			3.6 V	0 V					2	
			0 V	5.5 V					–1	
I_{CCB}		$V_I = V_O$ = Open, I_O = 0	1.2 V	1.65 V to 5.5 V		1.5				µA
			1.4 V to 3.6 V	2.3 V to 5.5 V					6	
			3.6 V	0 V					–1	
			0 V	5.5 V					1	
$I_{CCA} + I_{CCB}$		$V_I = V_{CCI}$ or GND, I_O = 0	1.2 V	2.3 V to 5.5 V		3				µA
			1.4 V to 3.6 V						8	
I_{CCZA}		$V_I = V_O$ = Open, I_O = 0, OE = GND	1.2 V	1.65 V to 5.5 V		0.05				µA
			1.4 V to 3.6 V						2	
I_{CCZB}		$V_I = V_O$ = Open, I_O = 0, OE = GND	1.2 V	1.65 V to 5.5 V		4				µA
			1.4 V to 3.6 V						6	
C_I	OE		3.3 V	3.3 V		4.5			5.5	pF
C_{io}	A port		3.3 V	3.3 V		6			7	pF
	B port					5.5			6	

(1) V_{CCO} is the V_{CC} associated with the output port.
(2) V_{CCI} is the V_{CC} associated with the input port.
(3) V_{CCA} must be less than or equal to V_{CCB}, and V_{CCA} must not exceed 3.6 V.

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TIMING REQUIREMENTS

T_A=25°C, V_{CCA} = 1.2 V

				V_{CCB} = 1.8 V	V_{CCB} = 2.5 V	V_{CCB} = 3.3 V	V_{CCB} = 5 V	UNIT
				TYP	TYP	TYP	TYP	
Data rate		Push-pull driving		20	20	20	20	Mbps
		Open-drain driving		1	1	1	1	
t_w	Pulse duration	Push-pull driving	Data inputs	50	50	50	50	ns
		Open-drain driving		500	500	500	500	

TIMING REQUIREMENTs

over recommended operating free-air temperature range, V_{CCA} = 1.5 V ± 0.1 V (unless otherwise noted)

				V_{CCB} = 1.8 V ± 0.15 V		V_{CCB} = 2.5 V ± 0.2 V		V_{CCB}= 3.3 V ± 0.3 V		V_{CCB}= 5 V ± 0.5 V		UNIT
				MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
Data rate		Push-pull driving			40		60		60		50	Mbps
		Open-drain driving			1		1		1		1	
t_w	Pulse duration	Push-pull driving	Data inputs	25		16.7		16.7		20		ns
		Open-drain driving		500		500		500		500		

TIMING REQUIREMENTS

over recommended operating free-air temperature range, V_{CCA} = 1.8 V ± 0.15 V (unless otherwise noted)

				V_{CCB} = 1.8 V ± 0.15 V		V_{CCB} = 2.5 V ± 0.2 V		V_{CCB}= 3.3 V ± 0.3 V		V_{CCB}= 5 V ± 0.5 V		UNIT
				MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
Data rate		Push-pull driving			40		60		60		60	Mbps
		Open-drain driving			1		1		1		1	
t_w	Pulse duration	Push-pull driving	Data inputs	25		16.7		16.7		16.7		ns
		Open-drain driving		500		500		500		500		

TIMING REQUIREMENTS

over recommended operating free-air temperature range, V_{CCA} = 2.5 V ± 0.2 V (unless otherwise noted)

				V_{CCB} = 2.5 V ± 0.2 V		V_{CCB} = 3.3 V ± 0.3 V		V_{CC} = 5 V ± 0.5 V		UNIT
				MIN	MAX	MIN	MAX	MIN	MAX	
Data rate		Push-pull driving			60		60		60	Mbps
		Open-drain driving			1		1		1	
t_w	Pulse duration	Push-pull driving	Data inputs	16.7		16.7		16.7		ns
		Open-drain driving		500		500		500		

TIMING REQUIREMENTS

over recommended operating free-air temperature range, V_{CCA} = 3.3 V ± 0.3 V (unless otherwise noted)

				V_{CCB} = 3.3 V ± 0.3 V		V_{CC} = 5 V ± 0.5 V		UNIT
				MIN	MAX	MIN	MAX	
Data rate		Push-pull driving			60		60	Mbps
		Open-drain driving			1		1	
t_w	Pulse duration	Push-pull driving	Data inputs	16.7		16.7		ns
		Open-drain driving		500		500		

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SWITCHING CHARACTERISTICS

over recommended operating free-air temperature range, V_{CCA} = 1.2 V (unless otherwise noted)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	V_{CCB} = 1.8 V ± 0.15 V	V_{CCB} = 2.5 V ± 0.2 V	V_{CCB} = 3.3 V ± 0.3 V	V_{CCB} = 5 V ± 0.5 V	UNIT
				TYP	TYP	TYP	TYP	
t_{PHL}	A	B	Push-pull driving	6.5	5.9	5.7	5.5	ns
			Open-drain driving	11.9	11.1	11.0	11.1	
t_{PLH}			Push-pull driving	7.1	6.3	6.2	6.6	
			Open-drain driving	293	236	197	152	
t_{PHL}	B	A	Push-pull driving	6.4	6	5.8	5.6	ns
			Open-drain driving	8.5	6.8	6.2	5.9	
t_{PLH}			Push-pull driving	5.6	4.1	3.6	3.2	
			Open-drain driving	312	248	192	132	
t_{en}	OE	A or B	Push-pull driving	200	200	200	200	ns
t_{dis}	OE	A or B		16.8	13.9	13.2	13.5	ns
t_{rA}	A-port rise time		Push-pull driving	7.9	6.7	6.5	6.4	ns
			Open-drain driving	296	238	185	127	
t_{rB}	B-port rise time		Push-pull driving	6.3	3.3	1.8	1.5	ns
			Open-drain driving	236	164	115	60	
t_{fA}	A-port fall time		Push-pull driving	5.8	4.8	4.3	3.8	ns
			Open-drain driving	5.9	4.7	4.1	3.5	
t_{fB}	B-port fall time		Push-pull driving	4.6	2.8	2.2	1.9	
			Open-drain driving	4.5	2.7	2.2	1.9	
$t_{SK(O)}$	Channel-to-channel skew		Push-pull driving	1	1	1	1	ns
Max data rate	A or B		Push-pull driving	20	20	20	20	Mbps
			Open-drain driving	1	1	1	1	

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SWITCHING CHARACTERISTICS

over recommended operating free-air temperature range, V_{CCA} = 1.5 V ± 0.1 V (unless otherwise noted)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	V_{CCB} = 1.8 V ± 0.15 V		V_{CCB} = 2.5 V ± 0.2 V		V_{CCB} = 3.3 V ± 0.3 V		V_{CCB} = 5 V ± 0.5 V		UNIT
				MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t_{PHL}	A	B	Push-pull driving		11		9.2		8.6		8.6	ns
			Open-drain driving	4	14.4	3.6	12.8	3.5	12.2	3.5	12	
t_{PLH}			Push-pull driving		12		10		9.8		9.7	
			Open-drain driving	182	720	143	554	114	473	81	384	
t_{PHL}	B	A	Push-pull driving		12.7		11.1		11		12	ns
			Open-drain driving	3.4	13.2	3.1	9.6	2.8	8.5	2.5	7.5	
t_{PLH}			Push-pull driving		9.5		6.2		5.1		1.6	
			Open-drain driving	186	745	147	603	118	519	84	407	
t_{en}	OE	A or B	Push-pull driving		200		200		200		200	ns
t_{dis}	OE	A or B			28.1		22		20.1		19.6	ns
t_{rA}	A-port rise time		Push-pull driving	3.5	13.1	3	9.8	3.1	9	3.2	8.3	ns
			Open-drain driving	147	982	115	716	92	592	66	481	
t_{rB}	B-port rise time		Push-pull driving	2.9	11.4	1.9	7.4	0.9	4.7	0.7	2.6	ns
			Open-drain driving	135	1020	91	756	58	653	20	370	
t_{fA}	A-port fall time		Push-pull driving	2.3	9.9	1.7	7.7	1.6	6.8	1.7	6	ns
			Open-drain driving	2.4	10	2.1	7.9	1.7	7	1.5	6.2	
t_{fB}	B-port fall time		Push-pull driving	2	8.7	1.3	5.5	0.9	3.8	0.8	3.1	
			Open-drain driving	1.2	11.5	1.3	8.6	1	9.6	0.5	7.7	
$t_{SK(O)}$	Channel-to-channel skew		Push-pull driving		1	1	1		1.1		1	ns
Max data rate	A or B		Push-pull driving		40		60		60		50	Mbps
			Open-drain driving		1	1	1		1		1	

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SWITCHING CHARACTERISTICS

over recommended operating free-air temperature range, V_{CCA} = 1.8 V ± 0.15 V(unless otherwise noted)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	V_{CCB} = 1.8 V ± 0.15 V		V_{CCB} = 2.5 V ± 0.2 V		V_{CCB} = 3.3 V ± 0.3 V		V_{CCB} = 5 V ± 0.5 V		UNIT
				MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t_{PHL}	A	B	Push-pull driving		8.2		6.4		5.7		5.6	ns
			Open-drain driving	3.6	11.4	3.2	9.9	3.1	9.3	3.1	8.9	
t_{PLH}			Push-pull driving		9		2.1		6.5		6.3	
			Open-drain driving	194	729	155	584	126	466	90	346	
t_{PHL}	B	A	Push-pull driving		9.8		8		7.4		7	ns
			Open-drain driving	3.4	12.1	2.8	8.5	2.5	7.3	2.1	6.2	
t_{PLH}			Push-pull driving		10.2		7		5.8		5	
			Open-drain driving	197	733	159	578	129	459	93	323	
t_{en}	OE	A or B	Push-pull driving		200		200		200		200	ns
t_{dis}	OE	A or B			25.1		18.8		16.5		15.3	ns
t_{rA}	A-port rise time		Push-pull driving	3.1	11.9	2.6	8.6	2.7	7.8	2.8	7.2	ns
			Open-drain driving	155	996	124	691	100	508	72	350	
t_{rB}	B-port rise time		Push-pull driving	2.8	10.5	1.8	7.2	1.2	5.2	0.7	2.7	ns
			Open-drain driving	132	1001	106	677	73	546	32	323	
t_{fA}	A-port fall time		Push-pull driving	2.1	8.8	1.6	6.6	1.4	5.7	1.4	4.9	ns
			Open-drain driving	2.2	9	1.7	6.7	1.4	5.8	1.2	5.2	
t_{fB}	B-port fall time		Push-pull driving	2	8.3	1.3	5.4	0.9	3.9	0.7	3	
			Open-drain driving	0.8	10.5	0.7	10.7	1	9.6	0.6	7.8	
$t_{SK(O)}$	Channel-to-channel skew		Push-pull driving		1		1		1		1	ns
Max data rate	A or B		Push-pull driving		40		60		60		60	Mbps
			Open-drain driving		1		1		1		1	

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SWITCHING CHARACTERISTICS

over recommended operating free-air temperature range, V_{CCA} = 2.5 V ± 0.2 V (unless otherwise noted)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	V_{CCB} = 2.5 V ± 0.2 V		V_{CCB} = 3.3 V ± 0.3 V		V_{CCB} = 5 V ± 0.5 V		UNIT
				MIN	MAX	MIN	MAX	MIN	MAX	
t_{PHL}	A	B	Push-pull driving		5		4		3.7	ns
			Open-drain driving	2.4	6.9	2.3	6.3	2.2	5.8	
t_{PLH}			Push-pull driving		5.2		4.3		3.9	
			Open-drain driving	149	592	125	488	93	368	
t_{PHL}	B	A	Push-pull driving		5.4		4.7		4.2	ns
			Open-drain driving	2.5	7.3	2.2	6	1.8	4.9	
t_{PLH}			Push-pull driving		5.9		4.4		3.5	
			Open-drain driving	150	595	126	481	94	345	
t_{en}	OE	A or B	Push-pull driving		200		200		200	ns
t_{dis}	OE	A or B			15.7		12.9		11.2	ns
t_{rA}	A-port rise time		Push-pull driving	2	7.3	2.1	6.4	2.2	5.8	ns
			Open-drain driving	110	692	93	529	68	369	
t_{rB}	B-port rise time		Push-pull driving	1.8	6.5	1.3	5.1	0.7	3.4	ns
			Open-drain driving	107	693	79	483	41	304	
t_{fA}	A-port fall time		Push-pull driving	1.5	5.7	1.2	4.7	1.3	3.8	ns
			Open-drain driving	1.5	5.6	1.2	4.7	1.1	4	
t_{fB}	B-port fall time		Push-pull driving	1.4	5.4	0.9	4.1	0.7	3	
			Open-drain driving	0.4	14.2	0.5	19.4	0.4	3	
$t_{SK(O)}$	Channel-to-channel skew		Push-pull driving		1		1.2		1	ns
Max data rate	A or B		Push-pull driving		60		60		60	Mbps
			Open-drain driving		1		1		1	

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SWITCHING CHARACTERISTICS

over recommended operating free-air temperature range, V_{CCA} = 3.3 V ± 0.3 V (unless otherwise noted)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	V_{CCB} = 3.3 V ± 0.3 V		V_{CCB} = 5 V ± 0.5 V		UNIT
				MIN	MAX	MIN	MAX	
t_{PHL}	A	B	Push-pull driving		3.8		3.1	ns
			Open-drain driving	2	5.3	1.9	4.8	
t_{PLH}			Push-pull driving		3.9		3.5	
			Open-drain driving	111	439	87	352	
t_{PHL}	B	A	Push-pull driving		4.2		3.8	ns
			Open-drain driving	2.1	5.5	1.7	4.5	
t_{PLH}			Push-pull driving		3.8		4.3	
			Open-drain driving	112	449	86	339	
t_{en}	OE	A or B	Push-pull driving		200		200	ns
t_{dis}	OE	A or B			11.9		9.8	ns
t_{rA}	A-port rise time		Push-pull driving	1.8	5.7	1.9	5	ns
			Open-drain driving	75	446	57	337	
t_{rB}	B-port rise time		Push-pull driving	1.5	5	1	3.6	ns
			Open-drain driving	72	427	40	290	
t_{fA}	A-port fall time		Push-pull driving	1.2	4.5	1.1	3.5	ns
			Open-drain driving	1.1	4.4	1	3.7	
t_{fB}	B-port fall time		Push-pull driving	1.1	4.2	0.8	3.1	
			Open-drain driving	1	4.2	0.8	3.1	
$t_{SK(O)}$	Channel-to-channel skew		Push-pull driving		1		1	ns
Max data rate	A or B		Push-pull driving		60		60	Mbps
			Open-drain driving		1		1	

OPERATING CHARACTERISTICS

T_A=25°C

PARAMETER		TEST CONDITIONS	V_{CCA}							UNIT
			1.2 V	1.2 V	1.5 V	1.8 V	2.5 V	2.5 V	3.3 V	
			V_{CCB}							
			5 V	1.8 V	1.8 V	1.8 V	2.5 V	5 V	3.3 V to 5 V	
			TYP	TYP	TYP	TYP	TYP	TYP	TYP	
C_{pdA}	A-port input, B-port output	C_L = 0, f = 10 MHz, t_r= t_f= 1ns, OE = V_{CCA} (outputs enabled)	5.9	5.7	5.9	5.9	6.7	6.9	8	pF
	B-port input, A-port output		10.2	10.3	9.9	9.7	9.7	9.4	9.8	
C_{pdB}	A-port input, B-port output		29.9	22.2	21.5	20.8	21	23.4	23	
	B-port input, A-port output		22.9	16.7	16.7	16.8	17.8	20.8	20.9	
C_{pdA}	A-port input, B-port output	C_L = 0, f = 10 MHz, t_r= t_f= 1ns, OE = GND (outputs disabled)	0.01	0.01	0.01	0.01	0.01	0.01	0.01	pF
	B-port input, A-port output		0.06	0.01	0.01	0.01	0.01	0.01	0.01	
C_{pdB}	A-port input, B-port output		0.06	0.01	0.01	0.01	0.01	0.03	0.02	
	B-port input, A-port output		0.06	0.01	0.01	0.01	0.01	0.03	0.02	

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PRINCIPLES OF OPERATION

Applications

The TXS0108E can be used in level-translation applications for interfacing devices or systems operating at different interface voltages with one another. The TXS0108E is ideal for use in applications where an open-drain driver is connected to the data I/Os. The TXS0108E can also be used in applications where a push-pull driver is connected to the data I/Os, but the TXB0104 might be a better option for such push-pull applications. The TXS0108E device is a semi-buffered auto-direction-sensing voltage translator design is optimized for translation applications (e.g. MMC Card Interfaces) that require the system to start out in a low-speed open-drain mode and then switch to a higher speed push-pull mode.

Architecture

To address these application requirements, a semi-buffered architecture design is used and is illustrated below (see Figure 1). Edge-rate accelerator circuitry (for both the high-to-low and low-to-high edges), a High-Ron n-channel pass-gate transistor (on the order of 300 Ω to 500 Ω) and pull-up resistors (to provide DC-bias and drive capabilities) are included to realize this solution. A direction-control signal (to control the direction of data flow from A to B or from B to A) is not needed. The resulting implementation supports both low-speed open-drain operation as well as high-speed push-pull operation.

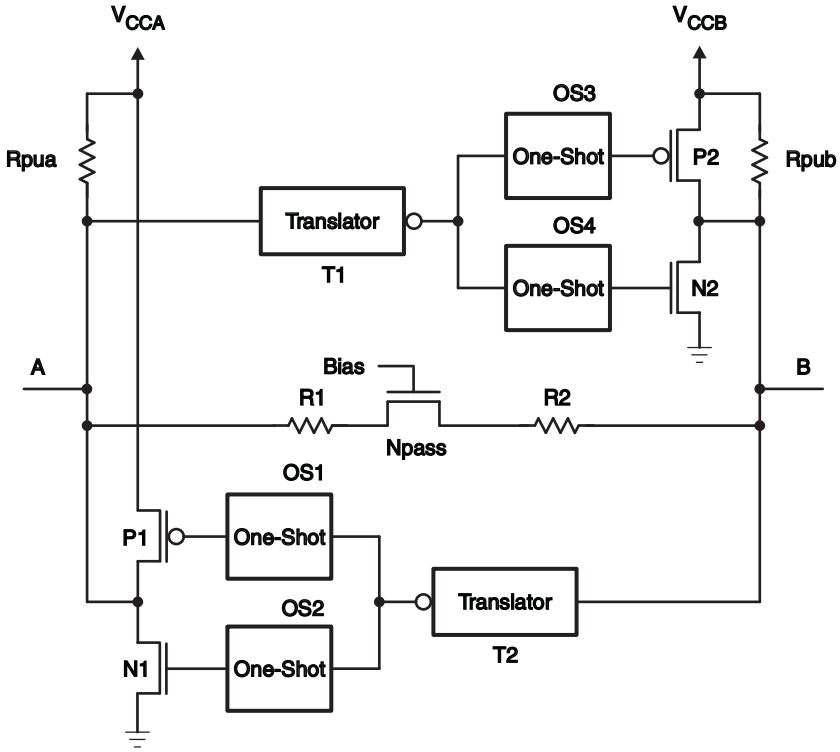


Figure 1. Architecture of a TXS01xx Cell

When transmitting data from A to B ports, during a rising edge the One-Shot (OS3) turns on the PMOS transistor (P2) for a short-duration and this speeds up the low-to-high transition. Similarly, during a falling edge, when transmitting data from A to B, the One-Shot (OS4) turns on NMOS transistor (N2) for a short-duration and this speeds up the high-to-low transition. The B-port edge-rate accelerator consists of one-shots OS3 and OS4, Transistors P2 and N2 and serves to rapidly force the B port high or low when a corresponding transition is detected on the A port.

When transmitting data from B to A ports, during a rising edge the One-Shot (OS1) turns on the PMOS transistor

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(P1) for a short-duration and this speeds up the low-to-high transition. Similarly, during a falling edge, when transmitting data from B to A, the One-Shot (OS2) turns on NMOS transistor (N1) for a short-duration and this speeds up the high-to-low transition. The A-port edge-rate accelerator consists of one-shots OS1 and OS2, Transistors P1 and N1 components and form the edge-rate accelerator and serves to rapidly force the A port high or low when a corresponding transition is detected on the B port.

Power Up

During operation, ensure that $V_{CCA} \leq V_{CCB}$ at all times. During power-up sequencing, $V_{CCA} \geq V_{CCB}$ does not damage the device, so any power supply can be ramped up first.

Enable and Disable

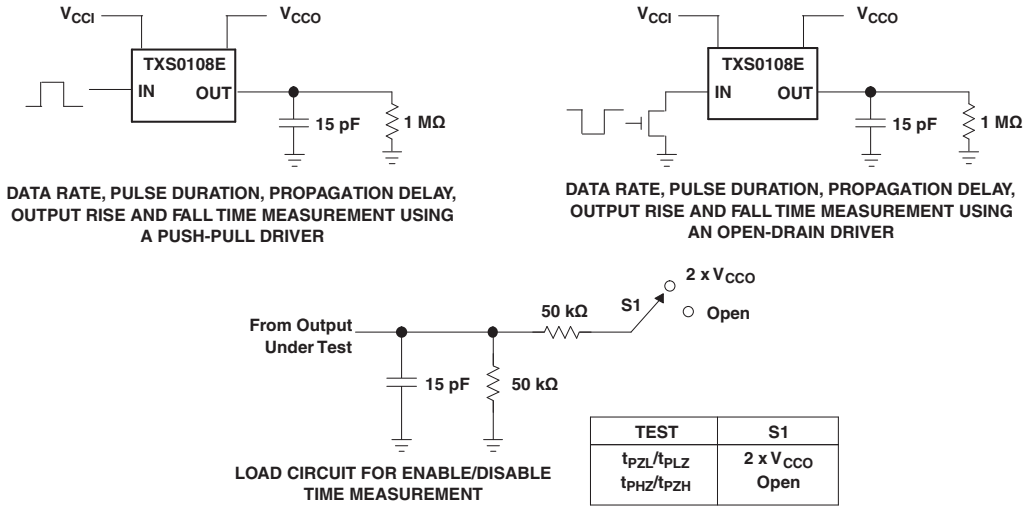
The TXS0108E has an OE input that is used to disable the device by setting OE low, which places all I/Os in the Hi-Z state. The disable time (t_{dis}) indicates the delay between the time when OE goes low and when the outputs actually get disabled (Hi-Z). The enable time (t_{en}) indicates the amount of time the user must allow for the one-shot circuitry to become operational after OE is taken high.

Pullup or Pulldown Resistors on I/O Lines

Each A-port I/O has a pull-up resistor (R_{pua}) to V_{CCA} and each B-port I/O has a pull-up resistor (R_{pub}) to V_{CCB}. R_{pua} and R_{pub} have a value of 40 kΩ when the output is driving low. R_{pua} and R_{pub} have a value of 4 kΩ when the output is driving high. R_{pua} and R_{pub} are disabled when OE = Low.

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PARAMETER MEASUREMENT INFORMATION



A. C_L includes probe and jig capacitance.

B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control.
Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.

C. All input pulses are supplied by generators having the following characteristics: PRR ≤ 10 MHz, ZO = 50 Ω, dv/dt ≥ 1 V/ns.

D. The outputs are measured one at a time, with one transition per measurement.

E. t_{PLZ} and t_{PHZ} are the same as t_{dis}.

F. t_{PZL} and t_{PZH} are the same as t_{en}.

G. t_{PLH} and t_{PHL} are the same as t_{pd}.

H. V_{CCI} is the V_{CC} associated with the input port.

I. V_{CCO} is the V_{CC} associated with the output port.

J. All parameters and waveforms are not applicable to all devices.

TEST	S1
t_{PZL}/t_{PLZ} t_{PHZ}/t_{PZH}	2 x V_{CCO} Open

Figure 2. Load Circuit and Voltage Waveforms

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PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp (3)
TXS0108EDGVR	PREVIEW	TVSOP	DGV	20	2000	TBD	Call TI	Call TI
TXS0108EGXYR	PREVIEW	BGA MICROSTAR JUNIOR	GXY	20	2500	TBD	Call TI	Call TI
TXS0108EPWR	ACTIVE	TSSOP	PW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TXS0108EPWRG4	ACTIVE	TSSOP	PW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TXS0108ERGYR	PREVIEW	QFN	RGY	20	1000	TBD	Call TI	Call TI
TXS0108EZXYR	ACTIVE	BGA MICROSTAR JUNIOR	ZXY	20	2500	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM

(1) The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.
TBD: The Pb-Free/Green conversion plan has not been defined.
Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.
Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.
Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

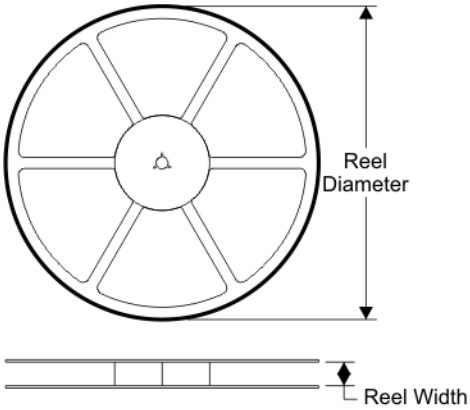
(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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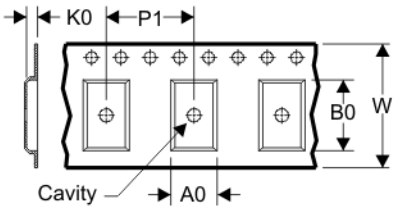
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TAPE AND REEL BOX INFORMATION

REEL DIMENSIONS

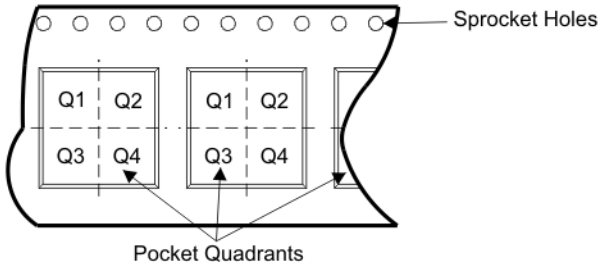


TAPE DIMENSIONS



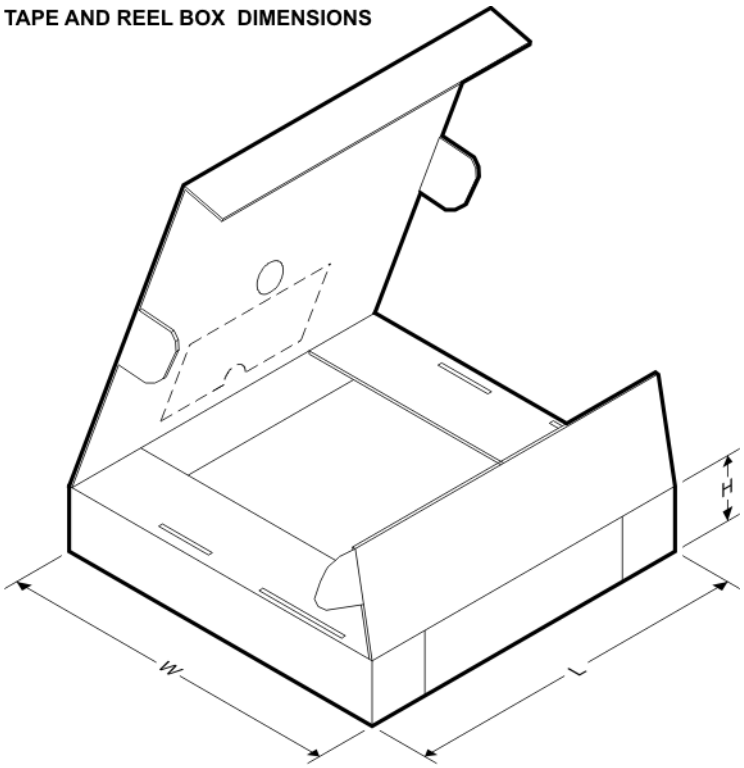
A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



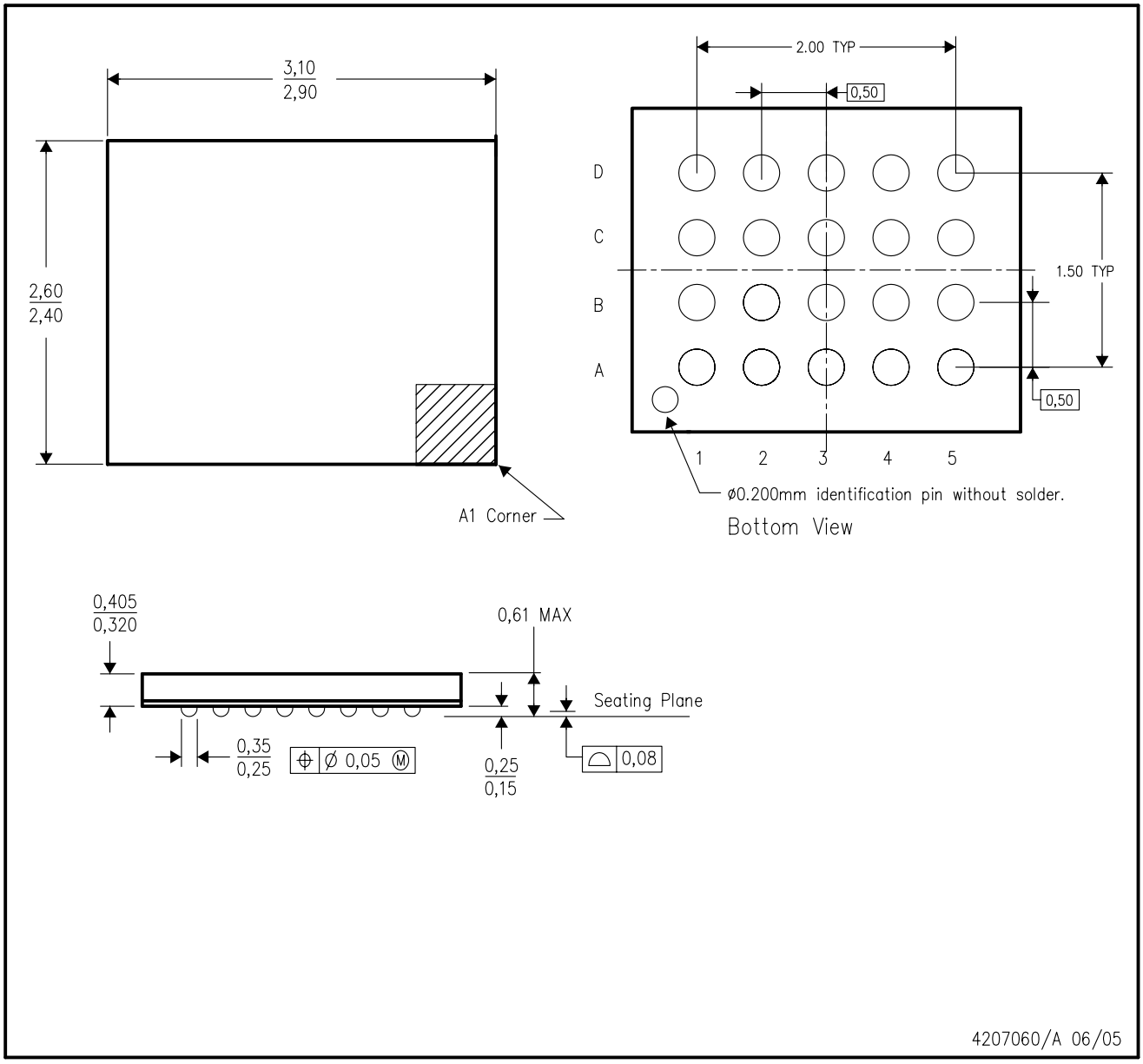
Device	Package	Pins	Site	Reel Diameter (mm)	Reel Width (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TXS0108EPWR	PW	20	SITE 41	330	16	6.95	7.1	1.6	8	16	Q1
TXS0108EZXYR	ZXY	20	SITE 60	330	12	2.8	3.3	1.0	4	12	Q2

TAPE AND REEL BOX DIMENSIONS



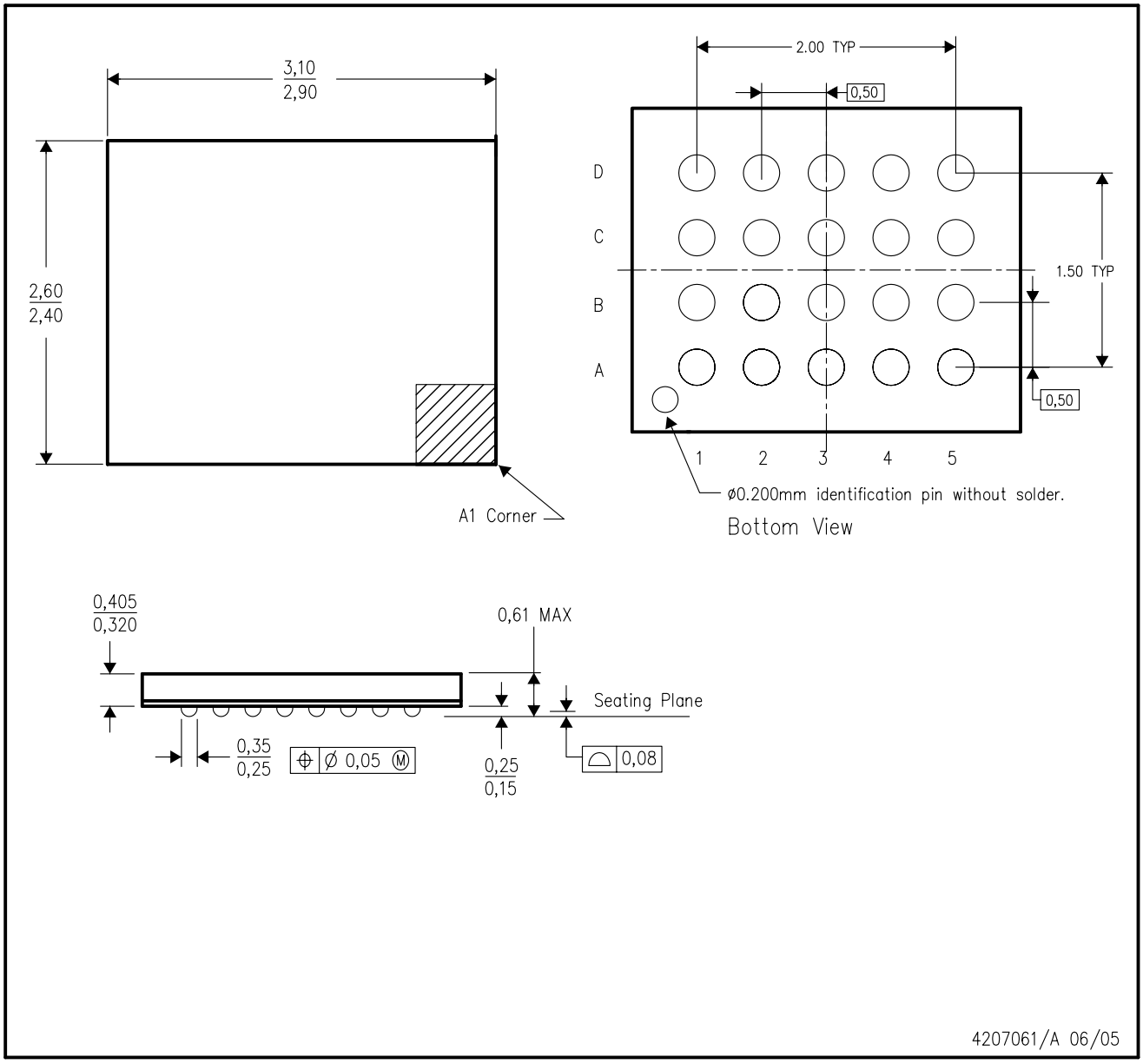
Device	Package	Pins	Site	Length (mm)	Width (mm)	Height (mm)
TXS0108EPWR	PW	20	SITE 41	346.0	346.0	33.0
TXS0108EZXYR	ZXY	20	SITE 60	342.9	338.1	20.64

GXY (S–PBGA–N20) PLASTIC BALL GRID ARRAY



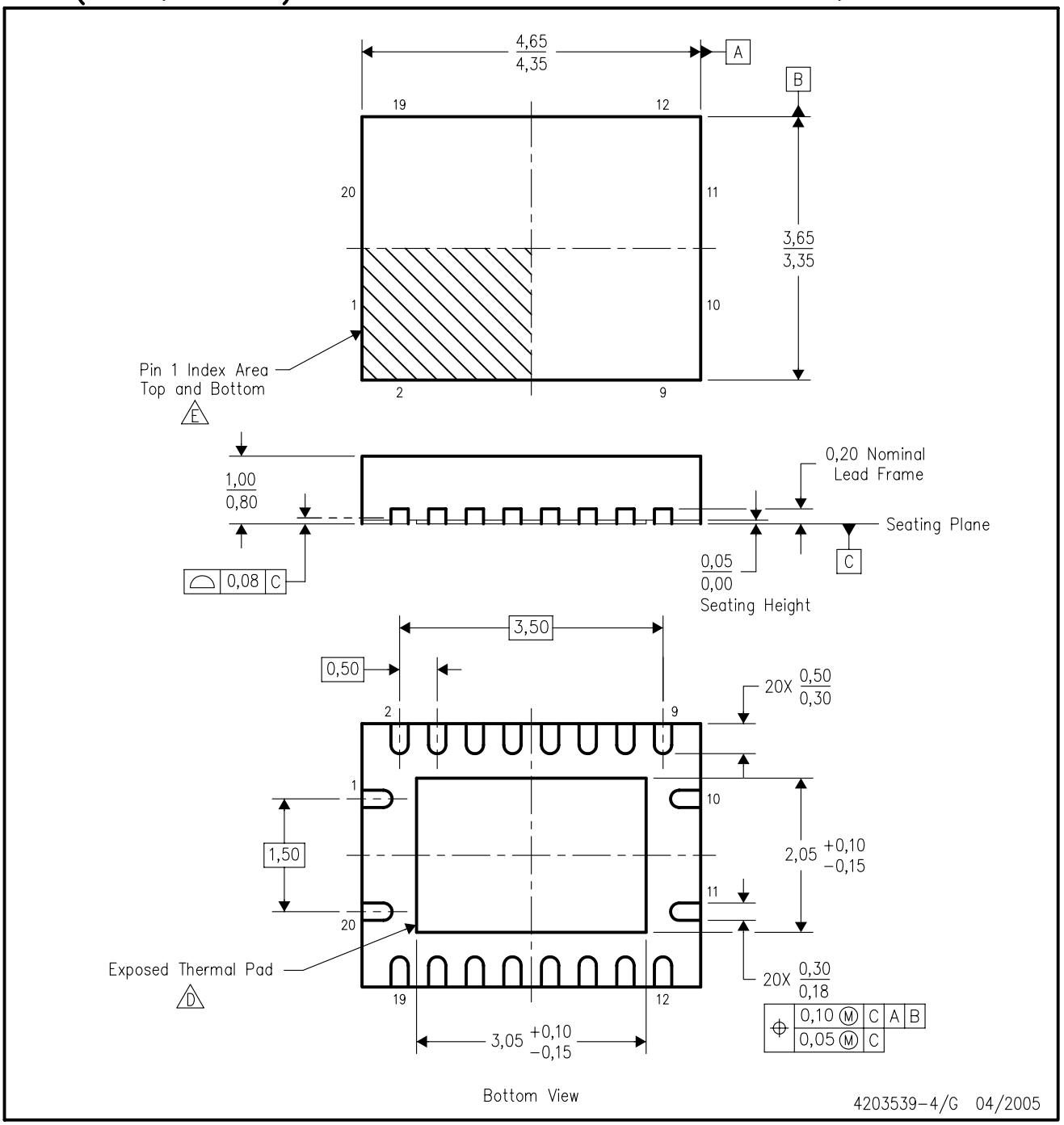
NOTES: A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.

ZXY (S–PBGA–N20) PLASTIC BALL GRID ARRAY



NOTES:
A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. This package is a lead–free solder ball design.

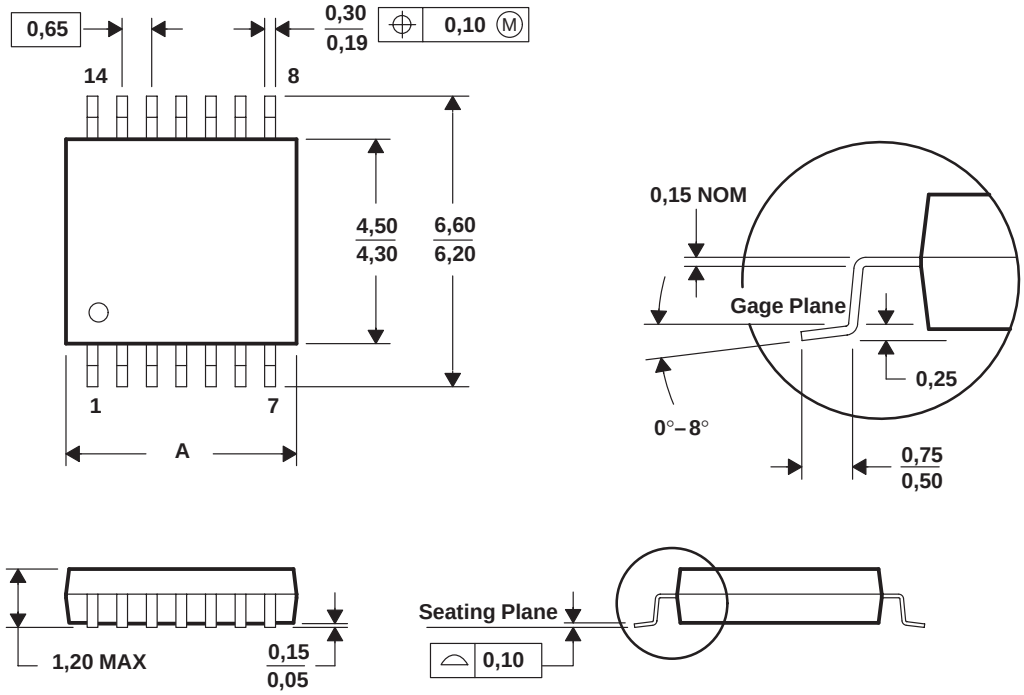
RGY (R–PQFP–N20) PLASTIC QUAD FLATPACK



NOTES:
A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M–1994.
B. This drawing is subject to change without notice.
C. QFN (Quad Flatpack No–Lead) package configuration.
D. The package thermal pad must be soldered to the board for thermal and mechanical performance.
E. Pin 1 identifiers are located on both top and bottom of the package and within the zone indicated. The Pin 1 identifiers are either a molded, marked, or metal feature.
F. Package complies to JEDEC MO–241 variation BC.

PW (R-PDSO-G)** **PLASTIC SMALL-OUTLINE PACKAGE**

14 PINS SHOWN



DIM \ PINS **	8	14	16	20	24	28
A MAX	3,10	5,10	5,10	6,60	7,90	9,80
A MIN	2,90	4,90	4,90	6,40	7,70	9,60

4040064/F 01/97

NOTES: A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
D. Falls within JEDEC MO-153

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